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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/668,159	XIE ET AL.	
Examiner	Art Unit	
John J. Goff	1733	

SEARCHED			
Class	Subclass	Date	Examiner
156	308.2, 308.6, 309.6	10/5/2005	JLG
429	33,40-44	. 10/5/2005	JLG
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Inventor Search - PALM	10/5/2005	JLG		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	10/5/2005	JLG		
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